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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Hisaya MORI, et al.

RESPONSE UNDER 37 CFR 1.116

EXPEDITED PROCEDURE

Application No.: 09/927,368

Customer No.: 20277

Filed: August 13, 2001

Confirmation No.: 4507

Group Art Unit: 2829

Examiner: J. M. Hollington

Title: APPARATUS AND METHOD FOR TESTING SEMICONDUCTOR INTEGRATED

CIRCUIT

REQUEST FOR RECONSIDERATION UNDER 37 CFR 1.116

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandría, VA 22313-1450

Sir:

This Request is submitted in response to the Office Action mailed August 12, 2004.

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